

RoHS

COMPLIANT

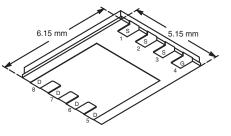
HALOGEN

FREE

Vishay Siliconix

N-Channel 100 V (D-S) MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$ $I_{D}\left(A\right)^{a}$ Q_{g}		Q _g (Typ.)	
100	0.014 at V _{GS} = 10 V	40		
	0.0148 at V _{GS} = 7.5 V	38	13.6 nC	
	0.019 at V _{GS} = 4.5 V	34		



PowerPAK[®] SO-8

Bottom View

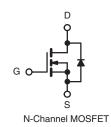
Ordering Information: SiR878DP-T1-GE3 (Lead (Pb)-free and Halogen-free)

FEATURES

- Halogen-free According to IEC 61249-2-21
 Definition
- TrenchFET[®] Power MOSFET
- 100 % R_g and UIS Tested
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- DC/DC Primary Side Switch
- Telecom/Server 48 V, Full/Half-Bridge DC/DC
- Industrial



Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	100	V	
Gate-Source Voltage		V _{GS}	± 20		
	T _C = 25 °C		40		
Continuous Drain Current (T ₁ = 150 °C)	T _C = 70 °C	1-	32		
Continuous Drain Current (1) = 150°C)	T _A = 25 °C	I _D	13.3 ^{b, c}		
	T _A = 70 °C		10.6 ^{b, c}	A	
Pulsed Drain Current		I _{DM}	80		
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	40		
	T _A = 25 °C	'S	4.5 ^{b, c}		
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	20		
Single Pulse Avalanche Energy	L = 0.1 1111	E _{AS}	20	mJ	
	T _C = 25 °C		44.5		
Maximum Power Dissipation	T _C = 70 °C	PD	28.5	w	
	T _A = 25 °C	' D	5 ^{b, c}	~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~	
	T _A = 70 °C		3.2 ^{b, c}		
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 150	℃		
Soldering Recommendations (Peak Temperature) ^{d, e}			260		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, f}	t ≤ 10 s	R _{thJA}	20	25	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	2.1	2.8	0/11	

Notes:

a. Based on T_C = 25 °C.

b. Surface mounted on 1" x 1" FR4 board.

c. t = 10 s.

d. See solder profile (<u>www.vishay.com/doc?73257</u>). The PowerPAK SO-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.

e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.

f. Maximum under steady state conditions is 70 °C/W.

SiR878DP

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static			<u> </u>				
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0, I_D = 250 \ \mu A$	100			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Γ		50			
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 5.5		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	1.2		2.8	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
Zara Cata Valtaga Drain Current	1	V _{DS} = 100 V, V _{GS} = 0 V			1		
Zero Gate Voltage Drain Current	I _{DSS}	V_{DS} = 100 V, V_{GS} = 0 V, T_{J} = 55 °C			10	μΑ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			А	
		$V_{GS} = 10 \text{ V}, I_D = 15 \text{ A}$		0.0114	0.014	Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 7.5 V, I _D = 12 A		0.0120	0.0148		
		V _{GS} = 4.5 V, I _D = 10 A		0.0152	0.0190		
Forward Transconductance ^a	9 _{fs}	V _{DS} = 10 V, I _D = 15 A		34		S	
Dynamic ^b	I						
Input Capacitance	C _{iss}			1250		pF	
Output Capacitance	C _{oss}	V _{DS} = 50 V, V _{GS} = 0 V, f = 1 MHz		680			
Reverse Transfer Capacitance	C _{rss}			50			
·	Qg	$V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 10 \text{ A}$		28.3	43	nC	
Total Gate Charge		$V_{DS} = 50 \text{ V}, V_{GS} = 7.5 \text{ V}, I_{D} = 10 \text{ A}$		21.6	33		
				13.6	20.5		
Gate-Source Charge	Q _{gs}	$V_{DS} = 50 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$		3.7			
Gate-Drain Charge	Q _{gd}			6.4			
Gate Resistance	R _g	f = 1 MHz	0.5	2.3	4.6	Ω	
Turn-On Delay Time	t _{d(on)}			9	18	- ns	
Rise Time	t _r	V_{DD} = 50 V, R_L = 5 Ω		11	22		
Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D}\cong$ 10 A, V_GEN = 10 V, R_g = 1 Ω		28	55		
Fall Time	t _f			10	20		
Turn-On Delay Time	t _{d(on)}			12	24		
Rise Time	t _r	V_{DD} = 50 V, R_L = 5 Ω		13	26		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ 10 A, V_{GEN} = 7.5 V, R_g = 1 Ω		27	50		
Fall Time	t _f			7	14		
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	۱ _S	$T_{\rm C} = 25 \ ^{\circ}{\rm C}$			40	А	
Pulse Diode Forward Current ^a	I _{SM}				80		
Body Diode Voltage	V _{SD}	I _S = 4 A		0.76	1.1	V	
Body Diode Reverse Recovery Time	t _{rr}			45	90	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	L = 10.4 d/dt = 100.4 km		50	100	nC	
Reverse Recovery Fall Time	t _a	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, \text{ T}_J = 25 ^\circ\text{C}$		21		ns	
Reverse Recovery Rise Time	t _b			24			

Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

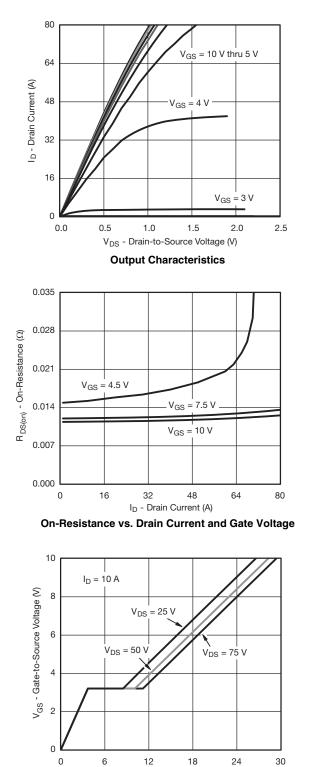
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



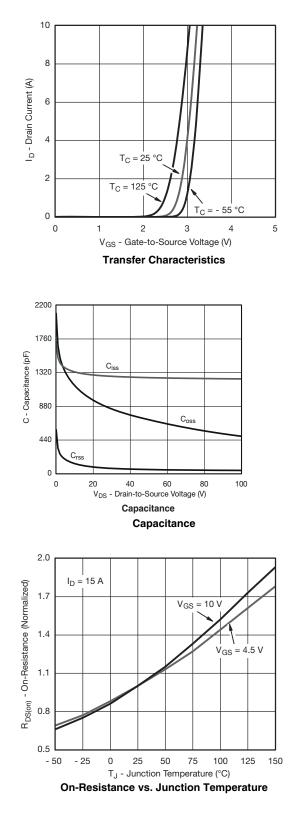
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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Qg - Total Gate Charge (nC)

Gate Charge

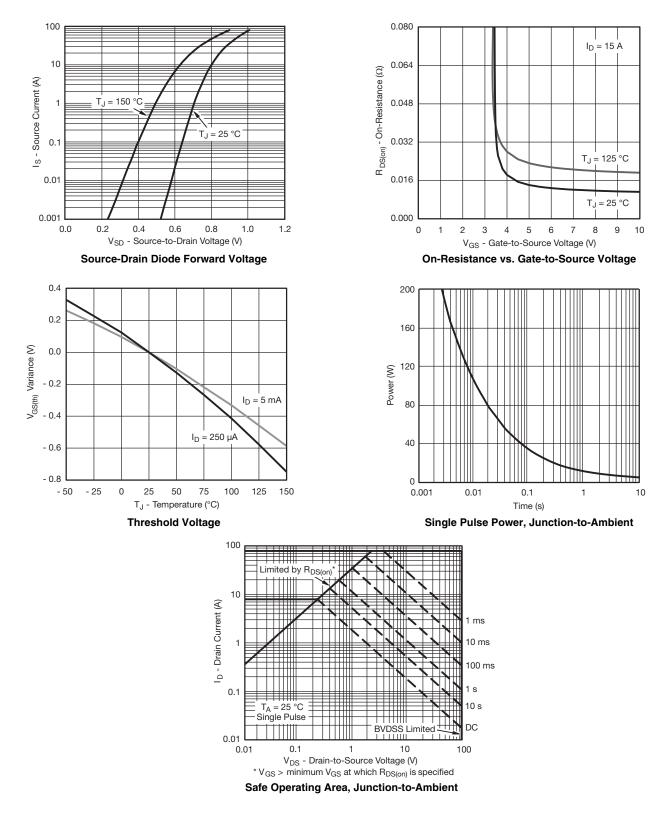


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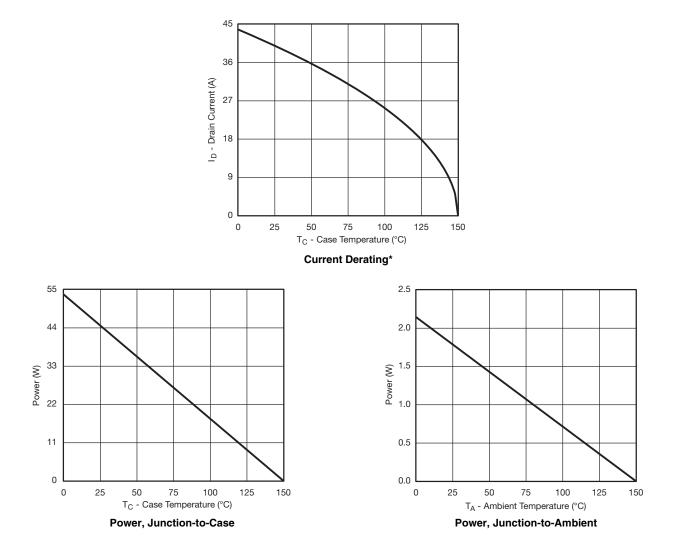
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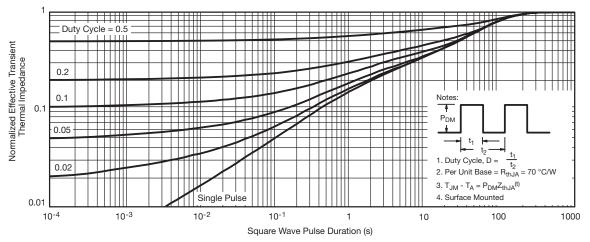


* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

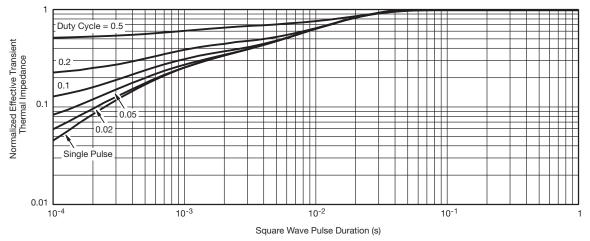


Vishay Siliconix

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?65939.



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